



1. Electrical Parameters

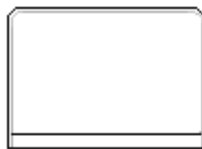
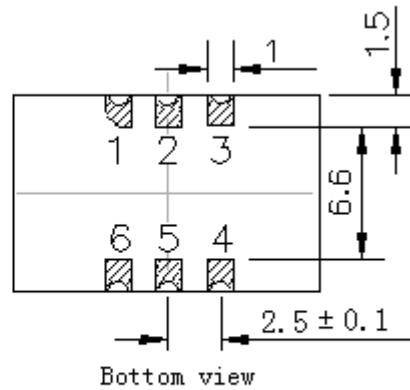
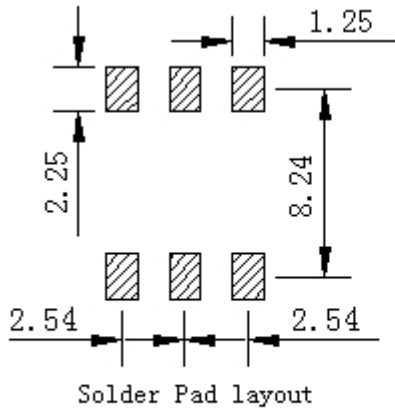
MODEL: O11H-2101-20.00MHz							
Item	Description	Parameters			Unit	Test Condition	
		Min.	Typ.	Max.			
Output	Frequency	20.00			MHz		
	Output Waveform	HCMOS					
	Output Low Voltage			0.33	V	$V_{cc}=3.3V, O_{load}=15pF$	
	Output High Voltage	2.4			V	$V_{cc}=3.3V, O_{load}=15pF$	
	Duty Cycle	45	50	55	%	@50%	
	Rise / Fall Time (10%~90%)			10	ns		
	Load	15			pF		
Frequency Stabilities	Frequency Tolerance vs. Operating Temperature Range	-0.03		+0.03	$\times 10^{-6}$	T_A varied from -40°C to 85°C, measurement referenced to frequency observed with $T_A=25^\circ C, V_{cc}=3.3V, O_{load}=15pF$, temperature variable speed less than 2°C per minute.	
	Initial Frequency Tolerance	-0.2		+0.2	$\times 10^{-6}$	Measurement referenced to frequency observed with $T_A=25^\circ C, V_{cc}=3.3V$, and after 15 minutes of operation, within 30 days after ex-works.	
	Frequency Tolerance vs. Supply Voltage	-0.01		+0.01	$\times 10^{-6}$	measurement referenced to frequency observed $T_A=25^\circ C, V_{cc}$ varied from 3.13V to 3.47V, and $O_{Load}=15pF$.	
	Frequency Tolerance vs. Load	-0.01		+0.01	$\times 10^{-6}$	5% load change measurement referenced to frequency observed with $T_A=25^\circ C, V_{cc}=3.3V$, and $O_{Load}=15pF$.	
	ADEV				0.05	$\times 10^{-9}$	Temperature stability, no EMI/EMC or other interference, test after power for 24hours, 25°C; 1s.
					0.1	$\times 10^{-9}$	Temperature stability, no EMI/EMC or other interference, test after power for 24hours, 25°C; 10s.
					0.1	$\times 10^{-9}$	Temperature stability, no EMI/EMC or other interference, test after power for 24hours, 25°C; 100s.
					0.3	$\times 10^{-9}$	Temperature stability, no EMI/EMC or other interference, test after power for 48hours, 25°C; 1000s.
					0.6	$\times 10^{-9}$	Temperature stability, no EMI/EMC or other interference, test after power for 7 days, 25°C; 10000s.



	Aging Tolerance Per Day	-1		+1	$\times 10^{-9}$	V_{cc}, T_A constant measurement referenced to frequency observed with $T_A=25^\circ\text{C}, V_{cc}=3.3\text{V}$, and after 30 days of operation.
	Aging Tolerance Per Month	-0.025		+0.025	$\times 10^{-6}$	
	Aging Tolerance 1 Year	-0.1		+0.1	$\times 10^{-6}$	
	Aging Tolerance 10 Years	-1.5		+1.5	$\times 10^{-6}$	
	Overall stability	-2		+2	$\times 10^{-6}$	Inclusive of the following: - operating temperature -40°C to 85°C - $3.3\text{V}\pm 5\%$ - 15pF load $\pm 5\%$ - 2 times reflow soldering - 10 years aging reference to nominal frequency
Power Supply	Supply Voltage	3.13	3.3	3.47	V	
	Steady Consumption			330	mA	@ 25°C
	Warm up current			750	mA	
	Warm-Up Time			3	minutes	@ 25°C to final frequency
Phase Noise	Phase Noise @ 25°C		-70	-60	dBc/Hz	1Hz
			-100	-90		10Hz
			-130	-120		100Hz
			-145	-135		1KHz
			-150	-145		10KHz
Environmental Conditions	Operable Temperature	-40		+85	$^\circ\text{C}$	
	Storage Temperature	-55		+105	$^\circ\text{C}$	
	ESD Level	Human Body Model, class2: 2000V to 4000V; ANSI/ESDA/JEDEC JS-001-2010.				
		Machine Model, class B: 200V to 400V; ANSI/ESDA/JEDEC JS-001-2010.				
	Moisture Sensitivity Level	Level 2.				
	Vibration	Test Condition: 0.75mm ;acceleration:10g;10Hz~500Hz, one cycle per 30 min, test 2 hour. (3 times for each 3 directions X ,Y , Z), IEC 68-2-06 Test Fc.				
Shock	50g; 11ms; half sine wave (3 times for each 3 directions X, Y, Z), IEC 68-2-27 Test Ea/Severity 50A.					



2. Mechanical Structure (mm)



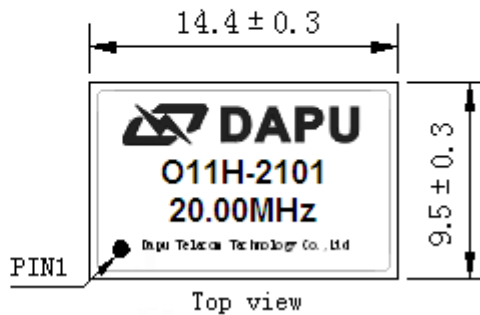
Right view



Side view

PIN FUNCTION

PIN	FUNCTION
1	NC
2,5	NC
3	GND
4	OUTPUT
6	VCC



Note1: Tolerance ± 0.2 mm without mark

Note2: Referential Weight 1.3g

Note3: NC is not connect

Note4: Material composition :

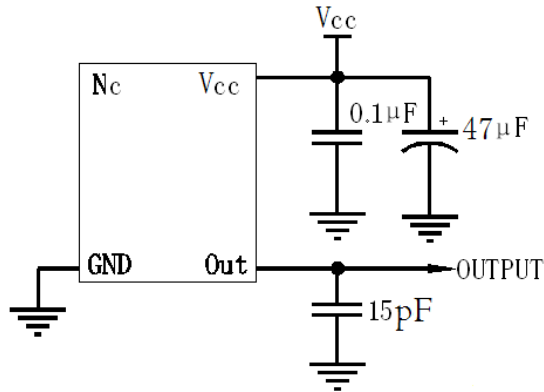
Pad/terminals: Cu (Surface plating: Ni 3-6um, Au 0.1~0.5um)

Base: High-TG FR4

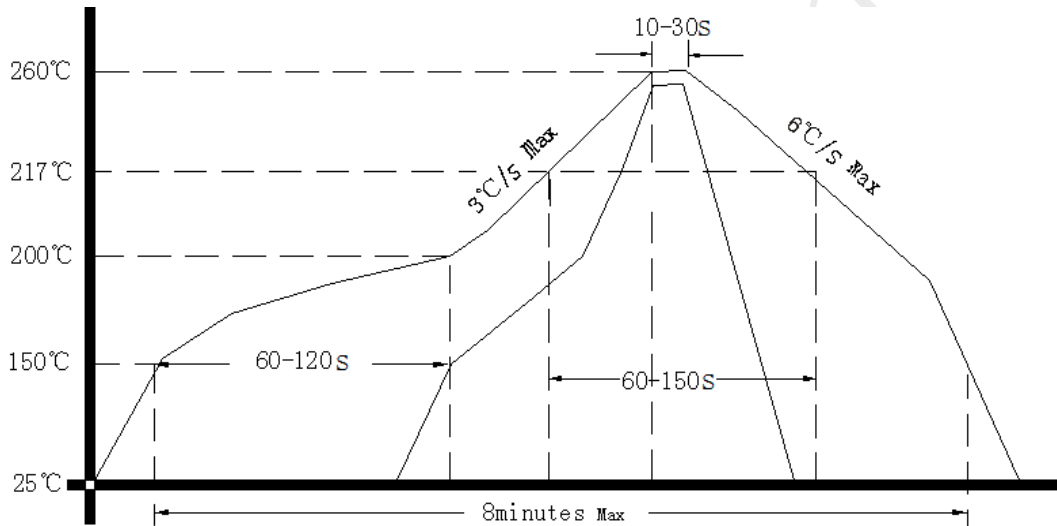
Cover: Stainless steel



3. Test Circuit



4. Reflow Soldering Curve (RoHS)



5. Package: Tape & Reel (mm)

